Search Notes

Application/Control No.

Applicant(s)/Patent under Reexamination

09/454,057

DOERENBERG ET AL.

Examiner

Art Unit 2176

Chau Nguyen

	SEAR	CHED	
Class	Subclass	Date	Examiner
710	25	6/22/2006	CN
710	29	6/22/2006	CN
710	39	6/22/2006	CN
710	45	6/22/2006	CN
710	117	6/22/2006	CN
710	126	6/22/2006	CN
710	100	. 1/31/2007	CN
710	106	1/31/2007	CN
710	107	1/31/2007	CN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
710	100	1/31/2007	CN
710	106	1/31/2007	CN
710	107	1/31/2007	CN
See Interfer	ext Search - ence Search stout	1/31/2007	CN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated Search on East Reports	1/12/2006	CN
Interference Search on East Reports	1/12/2006	CN
Discussed with SPRE Vincent Trans about Declaration 1.132	1/12/2006	CN
Updated Search on East Reports	6/22/2006	CN
	6/23/2006	CN
Updated Search on East Reports	1/30/2007	CN
•	1/31/2007	CN
NPL Search on IEEE Database	2/1/2007	CN



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/454,057	DOERENBERG ET AL.	
Examiner	Art Unit	
Chau Nguven	2176	

SEARCHED			
Class	Subclass	Date	Examiner
	÷		
	. '		
			·

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
-			
	L		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Discussed with Kakali Chali for 101	1/31/2007	CN
Discussed with Primary Glenn Auve for allowance and classifying to class 710/100	1/30/2007	CN
,		
	·	
•		
:		